# Interplay of intra- and interband absorption in a disordered graphene

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The absorption of heavily doped graphene in the terahertz and midinfrared spectral regions is considered, taking into account both the elastic scattering due to finite-range disorder and the variations of concentration due to long-range disorder. The interplay between intra- and interband transitions is analyzed for the high-frequency regime of response, near the Pauli blocking threshold. The gate voltage and temperature dependencies of the absorption efficiency are calculated. It is demonstrated that for typical parameters, the smearing of the interband absorption edge is determined by a partly screened contribution to long-range disorder while the intraband absorption is determined by finite-range scattering. The latter yields the spectral dependencies which deviate from those following from the Drude formula. The obtained dependencies are in agreement with recent experimental results. The comparison of the results of our calculations with the experimental data provides a possibility to extract the disorder characteristics.

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### I. INTRODUCTION

Both the gapless (massles) energy band structure and peculiarities of scattering mechanisms determine the response of graphene on the in-plane polarized radiation in the terahertz (THz) and midinfrared (MIR) spectral regions. Such a response is caused by both the direct interband transitions and the intraband transitions of free carriers accompanied by scattering processes (the Drude mechanism), see the reviews in Refs. 1–3 and references therein. The contributions of these two mechanisms in heavily doped graphene are described by the inter- and intraband dynamic conductivities,  $\sigma_{inter}$  and  $\sigma_{intra}$ , respectively, given by

$$\operatorname{Re}\sigma_{\operatorname{inter}} \approx \frac{e^2}{4\hbar} \theta(\hbar\omega - 2\varepsilon_F), \quad \sigma_{\operatorname{intra}}(\omega) \approx \frac{\sigma_F}{1 + i\omega\tau_F}, \quad (1)$$

where  $\varepsilon_F$  and  $\tau_F$  stand for the Fermi energy and the momentum relaxation time,  $\sigma_F = (e^2/4\hbar)\varepsilon_F \tau_F/\hbar$  is the static conductivity, and  $\theta(\varepsilon)$  is a unity step-like function. Here we have neglected a weak imaginary contribution  $\text{Im}\sigma_{\text{inter}}^4$  and the smearing of the interband absorption edge associated with the finiteness of the temperature T, and the collisional damping of the electron spectrum. When such a damping can be neglected at T = 0, the expression for  $\text{Re}\sigma_{\text{inter}}$  describes an abrupt jump at photon energy  $\hbar \omega = 2\varepsilon_F$  due to the Pauli blocking effect. The interband and intraband contributions are of the same order of magnitude at  $\omega \tau_F \sim \sqrt{4\varepsilon_F \tau_F / \pi \hbar - 1}$ . Therefore, the overlap of these contributions disappears if  $\varepsilon_F \tau_F / \hbar \ge 20$  [see Fig. 1(a)]. Thus, the description of interplay between both contributions is necessary in the THz (or MIR, depending on the doping level) spectral region for the typical samples with  $\hbar/\varepsilon_F \tau_F \ge 0.2$ . As shown below, the quasiclassical description of the intraband absorption and, therefore, the expression for  $\sigma_{intra}(\omega)$  based on the Drude formula is not valid if  $\hbar\omega$ exceeds the temperature of the carriers.<sup>5,6</sup> This is because of the variation of the relaxation time as a function of the electron energy over energy intervals  $\sim \hbar \omega$ , where the intraband transitions take place [see Fig. 1(b)].

The constant value for the interband conductivity  $\text{Re}\sigma_{\text{inter}}$ associated with the frequency-independent absorption was observed for undoped suspended graphene in the visible range of the spectrum.<sup>7</sup> By analogy with electrical transport in field-effect transistors, MIR spectroscopy allows for the control of the Pauli blocking effect using the electrical gating.<sup>8</sup> In sufficiently heavily doped graphene, the Drude mechanism of absorption was observed near the interband threshold, up to the MIR spectral region.<sup>9-11</sup> Despite a series of theoretical studies (see Refs. 12-14 and references therein), which have treated the problem of intra- and interband absorption at different levels of approximation, there are two drawbacks in the interpretation of the above-listed experimental data. First, the quantum description of the intraband absorption was not connected with the scattering parameters determined from the conductivity measurements and, second, an inhomogeneous smearing of the interband threshold due to long-range disorder was not considered. Thus, a reexamination of the intra- and interband absorption processes in a disorded graphene is timely now.

In this paper, we present a general consideration which is based on the Kubo formula and takes into account both the scattering due to finite-range disorder and *a long-range partly screened variation of concentration*. The latter contribution appears to be essential because the screening of the potential spatial variations associated with the disorder with the in-plane scales longer than (or comparable to) the distance to gate is suppressed. This mechanism is schematically illustrated in Figs. 1(c) and 1(d). As a result, the inhomogeneous mechanism of smearing of the interband absorption at  $\hbar \omega \sim 2\varepsilon_F$  should be taken into account, together with the thermal smearing of the Fermi distribution and broadening of the spectral density due to the elastic scattering on the finite-range disorder. The dynamic conductivity in the high-frequency range (if  $\omega \tau_F > 1$ ) is expressed via the Green's function, which is averaged over



FIG. 1. (Color online) (a) Spectral dependencies of  $\text{Re}\sigma(\omega)$  described by simplified Eq. (1) for different doping levels determined by  $\varepsilon_F \tau_F / \hbar$ . (b) Intra- and interband transitions between linear branches of gapless energy spectra. (c) Screening of nonuniform charge in ungated graphene with field distribution shown by dashed curves. (d) Gated graphene structure with partly screened charge and distribution of weak field shown by dotted curves.

the finite-range disorder, and the carrier distribution averaged over the long-range partly screened disorder. The averaged characteristics of the Green's function were obtained using the phenomenological description of the static conductivity similarly to Ref. 15. Considering the interplay of the intra- and interband contributions, we analyze the spectral, temperature, and gate voltage dependencies of the absorption efficiency. The obtained results are compared with the recent experimental data.<sup>10,11</sup> The fitting procedure demonstrates that the disorder characterization, including the evaluation of the parameters of high-energy scattering and long-range inhomogeneties, can be performed using the THz and MIR spectroscopy.

The paper is organized as follows. In the next section (Sec. II), we present the basic equations which describe the inter- and intraband mechanisms of absorption and consider partly screened long-range disorder in gated graphene. In Sec. III we analyze the spectra of relative absorption and their dependencies on the temperature disorder and as well as on the doping conditions. The last section includes the discussion of experimental data and the approximations used, and the conclusions.

# **II. BASIC EQUATIONS**

We start with the consideration of the dynamic conductivity based on the Kubo formula which takes into account elastic scattering and the partly screened long-range disorder. Since the absorption is determined by the real part of conductivity,  $\text{Re}\sigma_{\omega}$ , we neglect the Im $\sigma_{\omega}$  contribution.<sup>4</sup>

### A. Dynamic conductivity

Absorption of the THz (MIR) radiation propagating along the normal to the graphene layer is described by the real part of dynamic conductivity,<sup>6</sup> given by

$$\operatorname{Re}\sigma_{\omega} = \frac{2\pi e^{2}}{\omega L^{2}} \int dE (f_{E} - f_{E+\hbar\omega}) \\ \times \left\langle \sum_{\alpha\alpha'} |(\alpha|\hat{\upsilon}_{\parallel}|\alpha')|^{2} \delta(E - \varepsilon_{\alpha}) \delta(E - \varepsilon_{\alpha'} + \hbar\omega) \right\rangle.$$
(2)

Here  $L^2$  is the normalization area,  $f(\varepsilon_{\alpha})$  is the equilibrium distribution over the states  $|\alpha\rangle$  with energies  $\varepsilon_{\alpha}$ , and  $|(\alpha|\hat{\upsilon}_{\parallel}|\alpha')|^2$  is the matrix element of the in-plane velocity operator  $\hat{\upsilon}_{\parallel}$  between the states  $\alpha$  and  $\alpha'$  connected by the energy conservation law described by the  $\delta$  function. The  $\alpha$  states are defined by the eigenvalue problem  $(\hat{h} + V_x)\Psi_x^{(\alpha)} = \varepsilon_{\alpha}\Psi_x^{(\alpha)}$  expressed via the single-particle Hamiltonian  $\hat{h}$ , a random potential  $V_x$ , and the two-component wave function  $\Psi_{lx}^{(\alpha)}$  with l = 1, 2. The statistical averaging of Eq. (2) over the random potential is denoted as  $\langle \ldots \rangle$ . To perform this averaging, we introduce the spectral density function

$$A_{\varepsilon}(l\mathbf{x}, l'\mathbf{x}') = \sum_{\alpha} \delta(\varepsilon - \varepsilon_{\alpha}) \Psi_{l\mathbf{x}}^{(\alpha)} \Psi_{l'\mathbf{x}'}^{(\alpha)*}.$$
 (3)

Thus,  $\operatorname{Re}\sigma_{\omega}$  given by Eq. (1) is transformed into

$$\operatorname{Re}\sigma_{\omega} = \frac{2\pi (e\upsilon)^{2}}{\omega L^{2}} \int dE (f_{E} - f_{E+\hbar\omega}) \int d\mathbf{x}_{1} \int d\mathbf{x}_{2} \\ \times \langle \operatorname{tr}[\hat{A}_{E}(\mathbf{x}_{1}, \mathbf{x}_{2})\hat{\sigma}_{\parallel} \hat{A}_{E+\hbar\omega}(\mathbf{x}_{2}, \mathbf{x}_{1})\hat{\sigma}_{\parallel}] \rangle, \qquad (4)$$

where tr... means the trace over the isospin variable,  $v = 10^8 \text{ cm/s}$  is the characteristic velocity, and  $\hat{\sigma}_{\parallel} = (\hat{\sigma} \cdot \mathbf{e})$  is written through the 2 × 2 Pauli matrix  $\hat{\sigma}$  and the polarization ort  $\mathbf{e}$ .

Further, the spectral density function is expressed through the exact retarded and advanced Green's functions  $\hat{\mathcal{G}}_{E}^{R}(\mathbf{x}_{1},\mathbf{x}_{2})$  and  $\hat{\mathcal{G}}_{E}^{A}(\mathbf{x}_{1},\mathbf{x}_{2})$  as follows  $\hat{A}_{E}(\mathbf{x}_{1},\mathbf{x}_{2}) = i[\hat{\mathcal{G}}_{E}^{R}(\mathbf{x}_{1},\mathbf{x}_{2}) - \hat{\mathcal{G}}_{E}^{A}(\mathbf{x}_{1},\mathbf{x}_{2})]/2\pi$ . These Green's functions are governed by the standard equation

$$[E - i0 - \upsilon(\hat{\boldsymbol{\sigma}} \cdot \mathbf{p}_1) - u_{\mathbf{x}_1} - \upsilon_{\mathbf{x}_1}]\mathcal{G}_E^R(\mathbf{x}_1, \mathbf{x}_2) = \hat{1}\delta(\mathbf{x}_1 - \mathbf{x}_2),$$
(5)

which is written through the potential energy with separated contributions from finite- and long-range disorder,  $u_{\mathbf{x}_1}$  and  $v_{\mathbf{x}_1}$  labeled as fr- and lr- respectively. The averaging  $\langle \cdots \rangle_{fr}$ . It is convenient to introduce the variables  $(\mathbf{x}_1 + \mathbf{x}_2)/2 = \mathbf{x}$  and  $\mathbf{x}_1 - \mathbf{x}_2 = \Delta \mathbf{x}$  in Eqs. (4) and (5). Using these variables and neglecting a weak contribution of  $\nabla v_{\mathbf{x}}$  we obtain  $v_{\mathbf{x}+\Delta \mathbf{x}/2} \simeq v_{\mathbf{x}}$ . As a result, after the replacement  $E \to E + v$  one can separate the averaging over fr- and lr-disorder contributions and Eq. (4) takes the form

$$\operatorname{Re}\sigma_{\omega} = \frac{2\pi}{\omega} (e\upsilon)^{2} \int dE(\langle f_{E+\upsilon} \rangle_{lr} - \langle f_{E+\upsilon+\hbar\omega} \rangle_{lr}) \\ \times \int d\Delta \mathbf{x} \langle \operatorname{tr}[\hat{A}_{E}(\mathbf{x}_{1},\mathbf{x}_{2})\hat{\sigma}_{\parallel}\hat{A}_{E+\hbar\omega}(\mathbf{x}_{2},\mathbf{x}_{1})\hat{\sigma}_{\parallel}] \rangle_{fr},$$
(6)

where we take into account that  $\langle ... \rangle_{fr}$  depends only on  $|\Delta \mathbf{x}|$ and use  $\int d\mathbf{x} = L^2$ .

We consider below the high-frequency spectral region  $\omega \tau_F \gg 1$ , when the correlation function  $\langle \ldots \rangle_{fr}$  can be

factorized through the averaged spectral functions  $\hat{A}_{\Delta \mathbf{x}E} \equiv \langle \hat{A}_E(\mathbf{x}_1, \mathbf{x}_2) \rangle_{fr}$ . The averaging over fr disorder gives the contribution

$$\int d\Delta \mathbf{x} \langle \operatorname{tr}[\cdots] \rangle_{sr} = L^{-2} \sum_{\mathbf{p}} \operatorname{tr}(\hat{A}_{pE} \hat{\sigma}_{||} \hat{A}_{pE+\hbar\omega} \hat{\sigma}_{||}).$$
(7)

Here the spectral densities  $\hat{A}_{pE}$  should be written through the averaged Green's functions  $\hat{G}_{pE}^{A} = \hat{G}_{pE}^{R+}$  and  $\hat{G}_{pE}^{R}$ , which are given by the matrix expression

$$\hat{G}_{pE}^{R} = \left[E - \upsilon(\hat{\sigma} \cdot \mathbf{p}_{1}) - \hat{\Sigma}_{pE}^{R}\right]^{-1},$$

$$\hat{\Sigma}_{pE}^{R} = \zeta_{pE}^{R} + \frac{(\hat{\sigma} \cdot \mathbf{p})}{p} \eta_{pE}^{R},$$
(8)

where the self-energy function is determined in the Born approximation through the functions

. . .

$$\begin{vmatrix} \zeta_{pE}^{R} \\ \eta_{pE}^{R} \end{vmatrix} = \int \frac{d\mathbf{p_1}}{(2\pi\hbar)^2} W_{|\mathbf{p}-\mathbf{p}_1|} \\ \times \left| \frac{\frac{1}{E+i0-\upsilon p_1} + \frac{1}{E+i0+\upsilon p_1}}{\frac{(\mathbf{p}\cdot\mathbf{p}_1)}{pp_1} \left(\frac{1}{E+i0-\upsilon p_1} - \frac{1}{E+i0+\upsilon p_1}\right)} \right|.$$
(9)

Using the Fourier transformation of  $\langle u_{\mathbf{x}_1} u_{\mathbf{x}_2} \rangle_{fr} = \overline{u}^2 \exp[-(\mathbf{x}_1 - \mathbf{x}_2)^2/2l_{fr}^2]$ , one obtains in Eq. (9) the Gaussian correlation function  $W_{\Delta p}$  expressed through the strength of the potential and correlation length  $\overline{u}$  and  $l_{fr}$ . Because  $\hat{G}_{pE}^R$  depends only on the matrix ( $\hat{\sigma} \cdot \mathbf{p}$ ), the averaged spectral density of Eq. (7) takes the form

$$\hat{A}_{\mathbf{p}E} = \frac{A_{pE}^{(+)} + A_{pE}^{(-)}}{2} + \frac{(\hat{\sigma} \cdot \mathbf{p})}{2p} (A_{pE}^{(+)} - A_{pE}^{(-)}) A_{pE}^{(\pm)} = \frac{i}{2\pi} \left( \frac{1}{\varepsilon_{pE} \mp \upsilon_{pE}p} - \frac{1}{\varepsilon_{pE} \pm \upsilon_{pE}p} \right),$$
(10)

where we introduced the renormalized dispersion law and velocity  $\varepsilon_{pE} = E - \zeta_{pE}^{R}$  and  $\upsilon_{pE} = \upsilon(1 + \eta_{pE}^{R}/\upsilon p)$ , respectively.

For the averaging over lr disorder in Eq. (6) we introduce the population factor  $\langle f_{E+v} \rangle_{lr} = \int_{-\infty}^{\infty} dE' \phi_{E-E'} f_{E'}$  with the kernel  $\phi_{E-E'}$  determined by the characteristics of disorder, see Sec. II B. Thus, based on the two assumptions employed (the smoothness of lr-potential  $\nabla v \rightarrow 0$  and high-frequency approach  $\omega \tau_F \gg 1$ ) we obtain  $\text{Re}\sigma_{\omega}$  written through the triple integral

$$\operatorname{Re}\sigma_{\omega} = \frac{\pi (e\upsilon)^{2}}{\omega L^{2}} \int dE \int dE' \phi_{E-E'}(f_{E'} - f_{E'+\hbar\omega}) \\ \times \sum_{\mathbf{p}} (A_{pE}^{(+)} + A_{pE}^{(-)})(A_{pE+\hbar\omega}^{(+)} + A_{pE+\hbar\omega}^{(-)}), \quad (11)$$

where the contributions  $\propto A_{pE}^{(\pm)}A_{pE}^{(\pm)}$  and  $\propto A_{pE}^{(\pm)}A_{pE}^{(\mp)}$  correspond to the intra- and interband absorption processes, respectively. Similar expressions for the homogeneous case, without *lr* contribution, were considered in Ref. 13.

### B. Partly screened long-range disorder

Here we evaluate the square-averaged potential of lr disorder which is caused by a built-in random potential  $w_x$ .

We take into account the screening effect in the gated structure with the graphene sheet placed at z = 0 on the substrate of the width d and the static dielectric permittivity  $\epsilon$ , see Fig. 1(d). The electrostatic potential  $V_{\mathbf{x}z}$  is defined by the Poisson equation with the induced charge at z = 0 determined by the concentration of electrons in the heavily doped graphene  $n_{\mathbf{x}} = (4/L^4) \sum_{\mathbf{p}} \theta(\varepsilon_F - \varepsilon_{\mathbf{x}p}) = [(\varepsilon_F - v_{\mathbf{x}})/\sqrt{\pi} v\hbar]^2$ . The dispersion law  $\varepsilon_{p\mathbf{x}} = vp + v_{\mathbf{x}}$  is written here through the screened potential  $v_{\mathbf{x}} = w_{\mathbf{x}} + V_{\mathbf{x}z=0}$ . Performing the Fourier transformation over the  $\mathbf{x}$  plane one obtains the second-order equations for  $V_{\mathbf{q}z}^{<}$  and  $V_{\mathbf{q}z}^{>}$  which correspond to the substrate 0 > z > -dand to the upper half-space z > 0

$$\left(\frac{d^2}{dz^2} - q^2\right) \begin{vmatrix} V_{qz}^{>} \\ V_{qz}^{<} \end{vmatrix} = 0, \quad z > 0 \\ 0 > z > -d.$$
(12)

The jump of the electric field at z = 0 is defined by the charge distribution over graphene  $(z \rightarrow 0)$ 

$$\frac{dV_{\mathbf{q}z}^{2}}{dz}\Big|_{z=0} - \epsilon \frac{dV_{\mathbf{q}z}^{2}}{dz}\Big|_{z=0} = -\Psi_{\mathbf{q}}, \quad \Psi_{\mathbf{q}} = 4\pi e^{2} \int_{L^{2}} d\mathbf{x} e^{-i\mathbf{q}\mathbf{x}} n_{\mathbf{x}},$$
(13)

so that the potential remains homogeneous at z = 0:  $V_{qz=0}^{<} = V_{qz=0}^{>} \equiv V_{qz=0}$ . The boundary condition at z = -d is defined by the in-plane homogeneous back-gate voltage  $V_g$  as follows:  $V_{qz=-d}^{<} = V_g \delta_{q,0}$ . The last boundary condition is the requirement that the potential  $V_{qz}^{>}$  vanishes at  $z \to \infty$ .

The solution of this electrostatic problem can be written through  $\exp(\pm qz)$  and  $\Psi_q$  which depends on  $V_{qz=0}$  through the concentration  $n_x$ . Solving the system of the boundary conditions, we find that the screening potential at z = 0 should satisfy the requirement

$$V_{\mathbf{q}z=0} = -\Psi_{\mathbf{q}} dK(qd), \quad K(y) = \frac{\sinh y}{y(\sinh y + \epsilon \cosh y)}, \quad (14)$$

where the dimensionless function K describes the gateinduced quenching of  $V_{\mathbf{q}z=0}$  due to the fixed potential at z = -d. According to Eq. (13),  $\Psi_{\mathbf{q}}$  is the nonlinear function of the screened potential written through  $n_{\mathbf{x}}$  and the electrostatic problem given by Eqs. (12) and (13) is transformed into the integral equation for  $V_{\mathbf{q}z=0}$  determined by Eq. (14). Further, we consider the case of heavily doped graphene, when  $\varepsilon_F \gg |v_{\mathbf{x}}|$  and the electron-hole puddles are absent, so that  $n_{\mathbf{x}} \approx n_F(1 - 2v_{\mathbf{x}}/\varepsilon_F)$  is written through the averaged concentration  $n_F$ . As a result, the linearized dependency between  $\Psi_{\mathbf{q}}$  and the screened potential  $v_{\mathbf{q}}$  takes place

$$\Psi_{\mathbf{q}} \approx 4\pi e^2 n_F \left( \delta_{\mathbf{q},0} - \frac{2\nu_{\mathbf{q}}}{\varepsilon_F} \right). \tag{15}$$

Therefore, Eqs. (14) and (15) give the linear relation between  $V_{qz=0} = v_q - w_q$  and the Fourier component of the screened potential  $v_q$ . The solution for  $v_q$  takes form

$$v_{\mathbf{q}} = \frac{w_{\mathbf{q}}}{1 + 8(e/\hbar\upsilon)^2 \varepsilon_F dK(qd)},\tag{16}$$

where screening is suppressed (i.e.,  $v_q \rightarrow w_q$ ) if  $d \rightarrow 0$  and the complete screening  $(|v_q| \ll |w_q|)$  takes place at  $d \rightarrow \infty$ , when Eq. (16) coincides with the Thomas-Fermi approximation.

The averaging over lr disorder in the distribution  $\langle f_{E+v} \rangle_{lr}$  is performed after the Fourier transform of  $f_E$  with the use of



FIG. 2. (Color online) Dimensionless averaged potential  $\overline{v}$  versus  $d/l_{l_{r}}$  for different  $g_{F} = (1)$  12.5, (2) 25, (3) 50, and (4) 100.

the relation  $\langle \exp[iv_x \tau/\hbar] \rangle_{lr} = \exp[-(\overline{v}\tau/\hbar)^2/2]$ , where  $\overline{v} = \sqrt{\langle v_x^2 \rangle_{lr}}$  is the averaged lr potential. Under the inverse Fourier transformation (i.e., the integration over time) of the averaged distribution one obtains the result  $\langle f_{E+v} \rangle_{lr} = \int dE' \phi_{E-E'} f_{E'}$  which is written through the Gaussian kernel

$$\phi_{\Delta E} = \exp[-(\Delta E/\overline{v})^2/2]/(\sqrt{2\pi}\,\overline{v}) \tag{17}$$

with the half-width  $\overline{v}$ . Using Eq. (16) one can write  $\overline{v}$  through the averaged built-in potential  $w_q$ . We consider here a simple case of the Gaussian distribution of  $w_x$  described by the correlation function

$$\langle w_{\mathbf{q}}w_{\mathbf{q}'}\rangle_{lr} = L^2 \delta_{\mathbf{q}+\mathbf{q}',0} 2\pi l_{lr}^2 \overline{w}^2 \exp[-(q l_{lr})^2/2], \quad (18)$$

which is written through the correlation length  $l_{lr}$  and the averaged built-in potential  $\overline{w} = \sqrt{\langle w_x^2 \rangle_{lr}}$ . Using Eqs. (16) to (18) one obtains

$$\frac{\overline{v}}{\overline{w}} = \left\{ \int_0^\infty \frac{dx x e^{-x^2/2}}{[1 + g_F(d/l_l_r)K(xd/l_{l_r})]^2} \right\}^{1/2}, \quad (19)$$

and this ratio depends on  $d/l_{lr}$  and on the coupling constant,  $g_F = (8e^2/\hbar v)l_{lr}/\lambda_F \propto \varepsilon_F l_{lr}$ , written through the Fermi wavelength  $\lambda_F = v\hbar/\varepsilon_F$ . If  $d/l_{lr} \ll 1$  one obtains  $\overline{v}/\overline{w} \rightarrow 1$ and in the region  $d/l_{lr} \ge 1$  one obtains  $\overline{v}/\overline{w} \simeq \sqrt{(1+\epsilon)/g_F}$ which is independent on  $d/l_{lr}$ . In Fig. 2 we plot the function (19) for the case of SiO<sub>2</sub> substrate if the coupling constant  $g_F \simeq 10{-}100$  corresponds to the concentration range  $\sim 4 \times 10^{11}{-}4 \times 10^{13}$  cm<sup>-2</sup> and if  $l_{lr} \sim 50$  nm. With the increasing of  $n_F$  or  $l_{lr}$  at  $g_F > 100$ , the relation  $\overline{v}/\overline{w} \simeq \sqrt{(1+\epsilon)/g_F}$ appears to be valid for the interval of  $d/l_{lr} > 0.1$ .

# **III. RELATIVE ABSORPTION**

In this section we consider the absorption of radiation propagated along the normal to graphene sheet placed on a semi-infinite substrate with the high-frequency dielectric permittivity  $\kappa$ . Here we analyze the relative absorption coefficient

$$\xi_{\omega} \simeq \frac{16\pi \operatorname{Re}\sigma_{\omega}}{\sqrt{\kappa}(1+\sqrt{\kappa})^2 c} \tag{20}$$

neglecting the second-order corrections with respect to the parameter  $4\pi |\sigma_{\omega}|/c\sqrt{\kappa}$ . Note that the reflection and transmission coefficients  $R_{\omega}$  and  $T_{\omega}$  (these values are connected



FIG. 3. (Color online) Spectral dependencies of relative absorption in homogeneous graphene (normalized to  $\xi_{inter} = \xi_{\omega \to \infty}$ ) at temperatures 77 and 300 K (solid and dashed curves, respectively) for concentrations (1)  $5 \times 10^{11}$  cm<sup>-2</sup> and (2)  $10^{12}$  cm<sup>-2</sup>. Arrows correspond to the doubled Fermi energies and dotted curves are  $\propto \omega^{-2}$  asymptotics for Drude absorption.

by the energy conservation requirement  $R_{\omega} + T_{\omega} + \xi_{\omega} = 1$ ), involve the first-order correction  $\propto 4\pi |\sigma_{\omega}|/c\sqrt{\kappa}$  and the Re $\sigma_{\omega}$  contributions should be involved for the description of  $R_{\omega}$  and  $T_{\omega}$ .

### A. Spectral dependencies

First, we consider  $\xi_{\omega}$  given by Eq. (20) after substituting the dynamic conductivity determined by Eqs. (9) to (11). Performing the multiple integrations in  $\text{Re}\sigma_{\omega}$ , one obtains the spectral, gate voltage, and temperature dependencies of relative absorption. For calculations of the renormalized energy spectra and velocity defined by Eq. (9) we use here the typical parameters of fr disorder corresponding to the sample with the maximal sheet resistance  $\sim 3.5 \text{ k}\Omega$  and the correlation length  $l_{fr} \sim 7.5$  nm, see Ref. 15 for details. The level of longrange disorder  $\overline{v}$ , corresponding to  $l_{lr} \gg \lambda_F$ , is determined by the ratio  $d/l_{lr}$ , see Fig. 2; here we consider heavily doped graphene because a more complicated analysis is necessary for the case when electron-hole puddles are formed.<sup>16</sup>

The spectral dependencies of  $\xi_{\omega}$  normalized to the highfrequency interband contribution  $\xi_{inter}$  are plotted in Fig. 3 for the homogeneous graphene case  $\overline{v} = 0$  at concentrations  $5 \times 10^{11}$  cm<sup>-2</sup> and  $10^{12}$  cm<sup>-2</sup> for temperatures T = 77 and 300 K. Similarly to the schematic spectra in Fig. 1(a), one can separate contributions from intra- and interband transitions at  $\hbar\omega \sim 100$  and  $\sim 150$  meV for lower- and higher-doped samples with the minimal value of  $\xi_{\omega}/\xi_{\text{inter}} \sim 0.15$  and  $\sim 0.08$ , respectively. A visible deviation from the Drude spectral dependence ( $\propto \omega^{-2}$ ) takes place due to the quantum character of intraband transitions if  $\hbar \omega \ge T$ . Different signs of these deviations, which depend on  $\hbar\omega$ , T, and  $n_F$ , appear due to the complicated energy and momentum dependencies in Eqs. (9) and (10). The smearing of interband absorption around the Fermi energies ( $2\varepsilon_F$  are marked by arrows) is defined by both the scattering-induced broadening of the spectral density (10) and thermal effect (c.f. the solid and dashed curves in Fig. 3).

In addition, the inhomogeneous smearing of the interband absorption threshold due to partly screened long-range variations of concentration is essential, as it is shown in Fig. 4 for T = 77 K. Here we considered a strong *lr*-disorder case with



FIG. 4. (Color online) The same as in Fig. 3 at T = 77 K taking into account inhomogeneous smearing of threshold due to partly screened variations of concentrations around (1)  $5 \times 10^{11}$  cm<sup>-2</sup> and (2)  $10^{12}$  cm<sup>-2</sup>. Dashed curves are plotted for the homogeneous case  $\overline{v} = 0$ .

 $\overline{v} \simeq 30 \text{ meV}$  for  $n_F = 5 \times 10^{11} \text{ cm}^{-2}$  and  $\overline{v} \simeq 20 \text{ meV}$  for  $n_F = 10^{12} \text{ cm}^{-2}$  (we used the dependencies of Fig. 2 with  $\overline{w} \simeq 50 \text{ meV}$  and  $d/l_{lr} \leq 0.1$ ). Similarly to the thermally induced effect, the partly screened disorder effect results both in smearing of the interband absorption threshold and in enhancement of the minimal absorption in the region between intra- and interband contributions.

# B. Comparison with experiment

We turn now to a comparison of our calculations with the recent experimental data<sup>10,11</sup> where both the spectral dependencies of relative absorption in large-area samples and the static conductivity  $\sigma$  versus gate voltage  $V_g$  were measured. Using the phenomenological momentum relaxation rate  $v_p$  suggested in Ref. 15 and the experimental data for hole conductivity from Refs. 10 and 11, one can fit the dependency  $\sigma(V_g)$  as it is shown in Fig. 5. This approach gives us the fr-disorder scattering parameters for energies  $vp \leq 200 \text{ meV}$ and we can extrapolate these data up to ~400 meV energies, which are necessary for the description of the MIR response measured in Refs. 10 and 11.

In Fig. 6 we plot the spectral dependencies of relative absorption measured in Ref. 12 for graphene with hole concentrations ~2.2, ~4.3, and ~5.8 ×  $10^{12}$  cm<sup>-2</sup> at T = 100 K. Solid curves are plotted for the case of a homogeneous sample with the scattering parameters determined from the transport data shown in Fig. 5. These dependencies are in agreement with the experiment both in the intraband absorption region



FIG. 5. (Color online) Fitting of experimental data from Refs. 10 and 11 marked as 1 and 2: (a) momentum relaxation rate  $v_p$  versus energy vp and (b) sheet conductivity versus gate voltage. Squares and triangles are experimental points from Refs. (1) 10 and (2) 11, respectively.



FIG. 6. (Color online) Fitting of relative absorption spectra (normalized to  $\xi_{\text{inter}}$ ) to conditions of Ref. 10 at gate voltages (1) -30, (2), and (3) -80 V. Solid and dotted curves correspond to homogeneous and inhomogeneous (with  $\overline{w} \sim 150$  meV) samples. Squares, triangles, and diamonds are experimental points for the cases 1, 2, and 3, respectively. Arrows correspond to the doubled Fermi energies.

(at  $\hbar\omega \leq 150 \text{ meV}$ ) and above the threshold of interband absorption, at  $\hbar\omega > 2\varepsilon_F$ . But the absorption in the intermediate region  $\hbar\omega \sim 200\text{--}300 \text{ meV}$  appears to be suppressed in comparison to the experimental data. The minimal absorption increases if we take into account the partly screened *lr*-disorder contribution with  $\overline{v} \sim 80$ , 75, and 60 meV for curves 1, 2, and 3, respectively. Such values of  $\overline{v}$  are realized if  $\overline{w}$  is comparable to  $\varepsilon_F$  and  $d/l_{lr} \leq 0.1$  (i.e., the micrometer scale of inhomogeneities takes place, see Fig. 2). Thus, we have obtained a reasonable agreement with the experimental data. But the smearing of the interband threshold is stronger in comparison to the experimental data because the Gaussian model does not describe a real *lr* distribution. A more accurate description is possible with the use of *lr*-disorder parameters taken from additional structure measurements.

A similar fitting of  $\xi_{\omega}/\xi_{\text{inter}}$  measured in Ref. 11 for hole concentrations ~4.3, ~6.5, and ~8.6, and  $11 \times 10^{12}$  cm<sup>-2</sup> at T = 300 K is presented in Fig. 7. We plot the spectral dependencies both for the homogeneous sample (solid curves) and for the inhomogeneous sample taking into account the strong *lr* disorder (dotted curves) with  $\overline{v} \sim 120$ , 105, 90, and 75 meV for curves 1, 2, 3, and 4, respectively. Now, reasonable agreement with experimental data for interband



FIG. 7. (Color online) The same as in Fig. 6 for conditions of Ref. 11 at gate voltages (1) -30, (2) -60, (3) -90, and (4) -120 V. Squares, triangles, diamonds, and inverse triangles are experimental points for the cases 1, 2, 3, and 4, respectively.

absorption takes place (see the above discussion of Fig. 6 about the *lr*-disorder contribution) while the intraband absorption appears to be two to three times stronger in comparison to the disorder-induced contributions calculated. An additional contribution may appear due to relaxation via the emission of optical phonons of energy  $\hbar\omega_0$ . Such a channel of intraband absorption is allowed if  $\varepsilon_F > \hbar \omega_0$  and the rate of transitions is proportional to the density of states at  $\varepsilon_F - \hbar \omega_0$ . As a result, this process may be essential for the conditions of Ref. 11, where  $\varepsilon_F \ge 250$  meV, while this mechanism should be negligible at the lower concentrations and temperatures used in Ref. 10. Recent calculations of the phonon-induced intraband contribution<sup>17</sup> gives an additional absorption  $\sim 0.2\xi_{inter}$  for the conditions of Ref. 11. This contribution is of the order of the disagreement between calculations and experimental data presented in Fig. 7. More detailed experimental data, for the spectral range 200–400 meV at temperatures  $\leq 300$  K, are necessary to verify this contribution.

Overall, the comparison performed here demonstrates reasonable agreement with the experimental data, which opens a way for the verification of scattering mechanisms and longrange disorder parameters. The Drude spectral dependencies (for the region  $\leq 100 \text{ meV}$ ) were fitted to the experimental data in Refs. 10 and 11; our calculations are in good agreement with these data because we used the scattering parameters taken from the transport measurements. A complete verification can be performed under complex analysis which should include comparisons of spectroscopic data with (i) steadystate transport measurements of conductivity and Hall effect versus  $V_g$  and T, (ii) a structural (e.g., scanning tunneling microscopy) characterization of long-range disorder, and (iii) effect of large-area inhomogeneties (ripples, wrinkles, holes, etc.) in centimeter-sized samples.

### **IV. CONCLUSION**

We have examined the spectral, concentration (gate voltage), and temperature dependencies of the relative absorption due to intra- and interband transitions in graphene taking into account both elastic scattering and partly screened long-range variations of concentration. The smearing of the interband absorption edge, deviation from the Drude spectral dependence due to quantum regime of intraband transitions, and interplay of these two contributions are demonstrated. The results are in agreement with the recent experimental data obtained for heavily doped graphene.<sup>10,11</sup> This analysis allows to extract disorder parameters in the high-energy region (up to  $\hbar\omega$  above the Fermi energy).

Let us discuss the assumptions used in the calculations performed. The main restriction of the results is due to consideration of the high-frequency spectral region, when  $\operatorname{Re}\sigma_{\omega}$  can be written through the matrix product of the averaged spectral density functions (10). A more complicated description, based on the Bethe-Salpeter equation, is necessary for the low-frequency region  $\omega \tau_F \leq 1$ , which is beyond the scope of our consideration. This case is realized if  $\hbar\omega < 20$  meV, where the Drude dispertsion takes place, see Figs. 3 and 4. We also restrict ourselves by the phenomenological models for the finite-range disorder scattering<sup>15</sup> and for the partly screened long-range variations of concentration. It is enough for a description of spectral, gate voltage, and temperature dependencies of  $\xi_{\omega}$  because they are expressed through simple correlation functions which are similar for any microscopic nature of disorder. In addition, a long-range random strain<sup>18</sup> may have affect on the interband transitions in large-area samples. The scattering processes caused by phonons and carrier-carrier collisions should be analyzed under calculations of the intra- and interband absorption in clean samples. A possible contribution of optical phonons at room temperature<sup>11</sup> is discussed in Sec. III B (more detailed analysis is beyond of the scope of this paper) while the interaction with acoustic phonons is negligible. The Coulomb interaction changes the interband absorption in the UV spectral region due to the excitonic effect.<sup>19</sup> The comparison with the experiment was performed here for the hole doping case and electron-hole asymmetry reported in Refs. 10 and 11 is unclear. According to Refs. 20, the Coulomb-induced renormalization of the response and scattering processes give a weak contribution for typical disorder levels. This disagreement requires an additional investigation.

To conclude, we believe that our results open a way for the characterization of scattering processes and long-range inhomogeneities using THz and MIR spectroscopy. More importantly, that effect of disorder on THz and MIR response is the main factor which determines characteristics of different devices (e.g., lasers<sup>21</sup> and photodetectors<sup>22</sup>) in this spectral region. We believe that our study will stimulate a further investigation of these device applications.

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<sup>&</sup>lt;sup>4</sup>The imaginary contribution Im $\sigma_{\omega}$  is expressed through Re $\sigma_{\text{inter}}$  with the use of the Kramers-Kronig relation. Using a cutoff frequency correspondent to the width of valence band  $\varepsilon_m$  one obtains a weak contribution Im $\sigma_{\omega} \sim (\hbar\omega/2\pi\varepsilon_m)e^2/\hbar$ .

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